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Maximum RF Input Power BGU6101

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Application note

Document information

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Keywords	BGU6101, MMIC LNA, Maximum RF Input Power
Abstract	This document provides RF and DC test results by applying large RF input power.



Revision history

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1. Introduction

This document provides application examples and measurement results for large RF input signals using the BGU6101.

2. RF input power test on BGU6101

The test circuit shown in this document is using the BGU6101 and the input is matched between 1.8 – 2.2GHz (output is not matched). The Supply voltage is 4V and the bias current is set to 6mA. The test is done with and without series resistor of 50 ohm (MMIC Vcc is 3.7V) in the Vsupply line.

The input power is swept at 1.9 GHz from -20dBm up to 15dBm and kept for 2 hours at 15dBm in gain (Venable=Vcc) and 2 hours in off mode (Venable=0V).

After the test with 15dBm input power at 1.9GHz (17dB input return loss) the MMIC is tested on the Network analyzer on functionality.

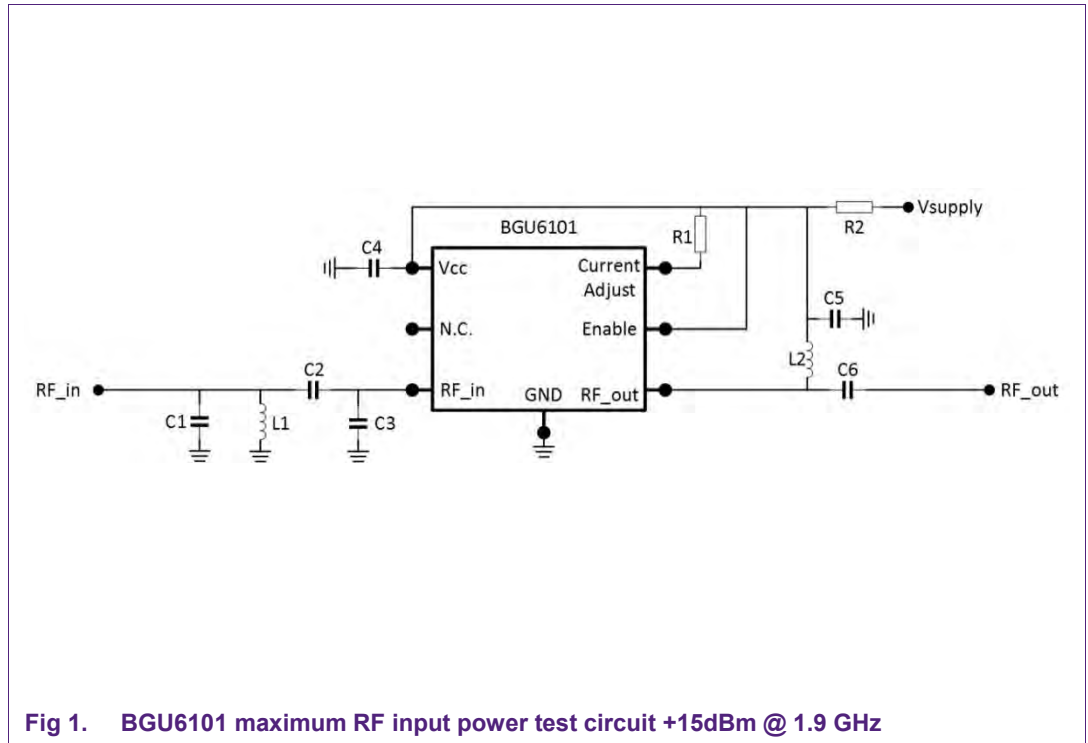


Fig 1. BGU6101 maximum RF input power test circuit +15dBm @ 1.9 GHz

The input of the BGU6101 is matched on the test frequency (RL in > 10dB), output is not matched.

Additional resistor (R2) is used to reduce the current caused by self-biasing at large input power.

BOM BGA6101 input match at 2GHz		
COMPONENT	Value	Function
C1	N.C.	
C2	2.2pF	matching
C3	1.8pF	matching
C4	4.7nF	decoupling
C5	4.7nF	decoupling
C6	47pF	dc-block
L1	3.3nH	matching
L2	27nH	bias
R1	5k	Rbias
R2	50R	Icc limit

Fig 2. BGA6101 BOM for 2GHz input matching

3. Test results with R2 = 50 ohm

BGU6101 Pin vs Pout & Icc (Vsupply =4V ; Vcc=3.7V ; Icc=6mA)						
Pin [dBm]	Test frequency 1.9GHz			Test frequency 2GHz		
	Pout [dBm]	Icc [mA]	Vcc [V]	Pout [dBm]	Icc [mA]	Vcc [V]
-30	-13.4	6	3.7	-14.2	6	3.7
-25	-8.5	6	3.7	-9.2	6	3.7
-20	-3.8	6	3.7	-4.5	6	3.7
-16	-0.5	6.1	3.7	-1.2	6.1	3.7
-15	0.1	6.1	3.7	-0.5	6.1	3.7
-10	2.6	6.6	3.7	2.2	6.5	3.7
-5	4.6	7.5	3.6	4.3	7.5	3.6
0	6.8	9.2	3.5	6.5	9.2	3.5
5	12.2	19.1	3	11.5	16.9	3.1
10	14.4	36.7	2.2	14.3	34.7	2.3
15	14.5	44.3	1.8	14.5	42.2	1.9

Fig 3. BGU6101 maximum RF input power versus Pout and Icc test results (P1dB in red)



Fig 4. BGU6101 S-parameter before and after 2 hours +15dBm RF input power test

4. Test results with R2=0 ohm (not recommended) and R1=6 kohm

BGU6101 Pin vs Pout & Icc (Vsupply =4V; Icc=6mA; @1.9GHz)						
Pin [dBm]	Gain mode (Venable=Vcc)			OFF mode (Venable =0V)		
	Pout [dBm]	Icc [mA]	Vcc [V]	Pout [dBm]	Icc [mA]	Vcc [V]
-30	-12.9	6	4	-57	0.004	4
-25	-8	6	4	-52	0.004	4
-20	-3.4	6	4	-47	0.004	4
-17	-1	6	4			
-15	0.3	6.1	4	-42	0.004	4
-10	2.6	6.5	4	-37	0.004	4
-5	4.3	7.5	4	-32.5	0.004	4
0	6.6	9.2	4	-27.6	0.004	4
5	12.3	18.9	4	10.6	13.7	4
10	16.2	44.8	4	16	41.8	4
15	17.9	64.5	4	17.7	61.5	4

Fig 5. BGU6101 maximum RF input power versus Pout and Icc test results (P1dB in red)

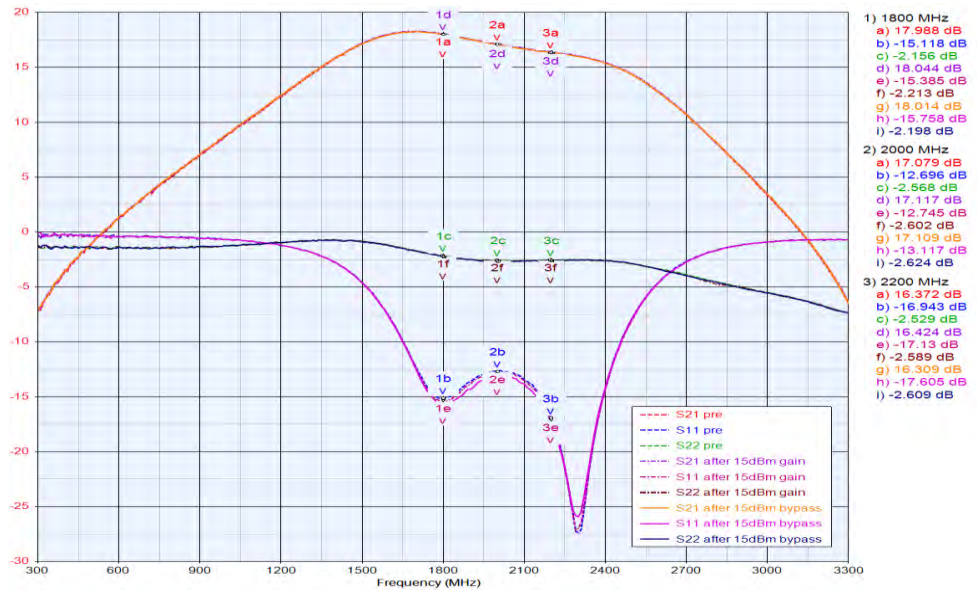


Fig 6. BGU6101 S-parameter before and after 2 hours +15dBm RF input power test in gain (Venable=Vcc) and off mode (Venable=0V)

5. Conclusion

After 2 hours stress with 15dBm at RF input using the input matched BGU6101, no changes on S-parameter and DC-biasing observed.

The test is done with R2=50 ohm and R2=0 ohm series resistor at the Vcc in gain and OFF mode.

To minimize the self-biasing (increase of Icc) we recommend additional series resistor R2 at the Vsupply, for details see the test schematic Fig.1.

In case of using the 50ohm series resistor at the Vsupply and different control voltage at the Venable can lead to voltage difference between Vcc and Venable higher than 1.8V ($V_{enable\ max} = V_{cc} + 1.8V$) and internal ESD protection diodes can start to conduct.

To protect the ESD diodes we recommend to use series resistor to limit the current on the Venable pin to max 20mA (5mA recommended) or limit the Venable voltage for gain mode to max. 2V (min. 1.2V).

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